

# **MOSFET** - N-Channel, QFET

## **800 V, 1.5 A, 6.3 m** $\Omega$

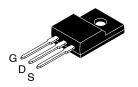
## FQPF2N80

#### Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

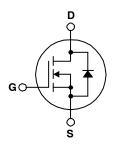
#### **Features**

- 1.5 A, 800 V,  $R_{DS(on)} = 6.3 \Omega$  (Max.) @  $V_{GS} = 10$  V, ID = 0.75 A
- Low Gate Charge (Typ. 12 nC)
- Low C<sub>rss</sub> (Typ. 5.5 pF)
- 100% Avalanche Tested

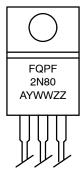


TO-220 Fullpack, 3-Lead / TO-220F-3SG CASE 221AT

#### **N-CHANNEL MOSFET**



#### **MARKING DIAGRAM**



FQPF2N80 = Specific Device Code
A = Assembly Location
YWW = Date Code (Year & Week)
ZZ = Assembly Lot

#### **ORDERING INFORMATION**

Device	Package	Shipping
FQPF2N80	TO-220 Fullpack	1,000 Units / Tube

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## **ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter		Value	Unit
$V_{DSS}$	Drain-Source Voltage		800	V
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)	1.5 0.95	A A
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	6.0	Α
V <sub>GSS</sub>	Gate-Source Voltage		±30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		180	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)		1.5	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		3.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.0	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C) – Derate Above 25°C		35 0.28	W W/°C
$T_{J_i} T_{STG}$	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL CHARACTERISTICS

Symbol	bol Parameter		Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case, Max.	3.57	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W

## **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
OFF CHARACTERISTICS								
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	800	_	-	V		
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C	-	0.9	-	V/°C		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C	-	- -	10 100	μ <b>Α</b> μ <b>Α</b>		
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	-	_	100	nA		
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{V}$	-	_	-100	nA		
ON CHARA	ON CHARACTERISTICS							
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3.0	_	5.0	V		
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.75 A	-	4.6	6.3	Ω		
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.75 A	-	2.2	-	S		
DYNAMIC CHARACTERISTICS								
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	-	425	550	pF		
C <sub>oss</sub>	Output Capacitance	]	-	45	60	pF		
C <sub>rss</sub>	Reverse Transfer Capacitance	1	-	5.5	7.0	pF		

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)(continued)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
SWITCHIN	G CHARACTERISTICS	•	•	•		•
t <sub>d(on)</sub>	Turn-On Delay Time			12	35	ns
t <sub>r</sub>	Turn-On Rise Time	R <sub>G</sub> = 25 Ω (Note 4)	-	30	70	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	25	60	ns
t <sub>f</sub>	Turn-Off Fall Time		-	28	65	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 640 V, I <sub>D</sub> = 2.4 A, V <sub>GS</sub> = 10 V (Note 4)	-	12	15	nC
Q <sub>gs</sub>	Gate-Source Charge		-	2.6	-	nC
$Q_{gd}$	Gate-Drain Charge		-	6.0	-	nC
RAIN-SC	DURCE DIODE CHARACTERISTICS AND M	NAXIMUM RATINGS				
IS	Maximum Continuous Drain-Source Diode Forward Current		-	_	1.5	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current		-	-	6.0	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.5 \text{ A}$	-	-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.4 A, dI <sub>F</sub> /dt = 100 A/μs	-	480	_	ns
Q <sub>rr</sub>	Reverse Recovery Charge		_	2.0	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. Repetitive rating: pulse–width limited by maximum junction temperature.

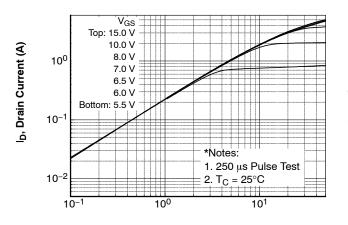
2. L = 150 mH,  $I_{AS}$  = 1.5 A,  $V_{DD}$  = 50 V,  $R_{G}$  = 25  $\Omega$ , starting  $T_{J}$  = 25°C.

3.  $I_{SD} \le 2.4$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , starting  $T_{J}$  = 25°C.

4. Essentially independent of operating temperature.

#### **TYPICAL CHARACTERISTICS**

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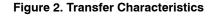


<sub>D</sub>, Drain Current (A) 150°C 10<sup>0</sup> -55°C 25°C \*Notes: 1. V<sub>DS</sub> = 50 V 2. 250 µs Pulse Test

V<sub>DS</sub>, Drain-Source Voltage (V)

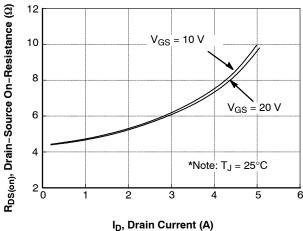
Figure 1. On-Region Characteristics

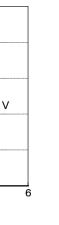
V<sub>GS</sub>, Gate-Source Voltage (V)



8

10





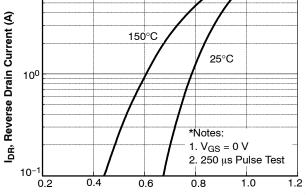
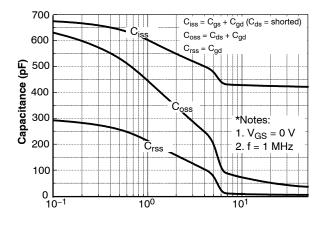


Figure 3. On-Resistance Variation vs. Drain

**Current and Gate Voltage** 

Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

V<sub>SD</sub>, Source-Drain Voltage (A)



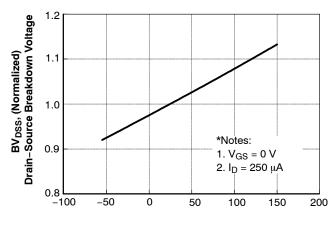
12 V<sub>DS</sub> = 160 \  $V_{DS} = 400 V$ V<sub>GS</sub>, Gate-Source Voltage (V) 10 V<sub>DS</sub> = 640 V 8 6 \*Note: I<sub>D</sub> = 2.4 A 2 0 2 6 8 10 12 14

V<sub>DS</sub>, Drain-Source Voltage (V)

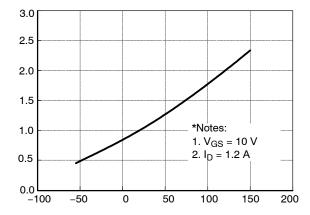
Q<sub>G</sub>, Total Gate Charge (nC) Figure 6. Gate Charge Characteristics

Figure 5. Capacitance Characteristics

#### TYPICAL CHARACTERISTICS (continued)



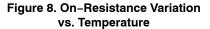
R<sub>DS(ON)</sub>, (Normalized) Drain-Source On-Resistance

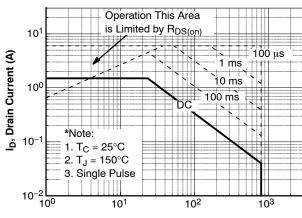


 $T_J$ , Junction Temperature (°C)

Figure 7. Breakdown Voltage Variation vs. Temperature

T<sub>J</sub>, Junction Temperature (°C)







0.0 L 25



75

V<sub>DS</sub>, Drain-Source Voltage (V)

Figure 9. Maximum Safe Operating Area

T<sub>C</sub>, Case Temperature (°C)

100

125

150

Figure 10. Maximum Drain Current vs. Case Temperature

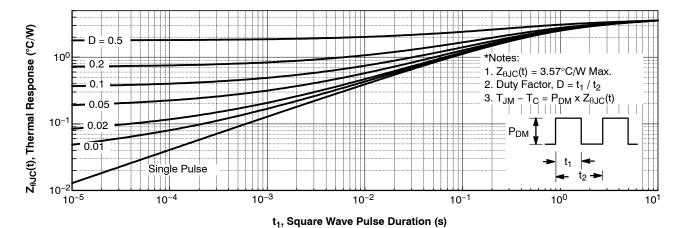


Figure 11. Transient Thermal Response Curve

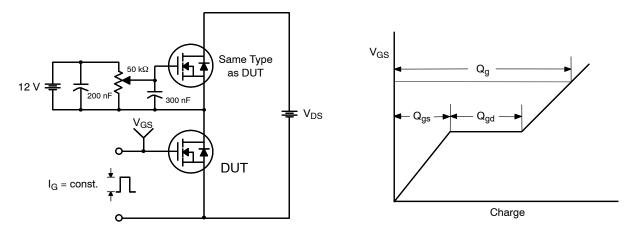


Figure 12. Gate Charge Test Circuit & Waveform

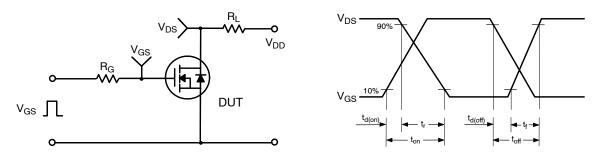


Figure 13. Resistive Switching Test Circuit & Waveforms

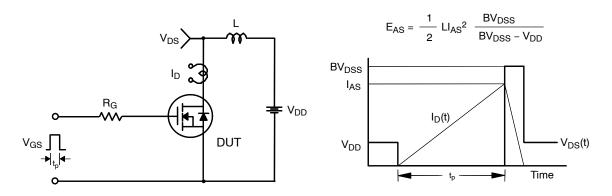
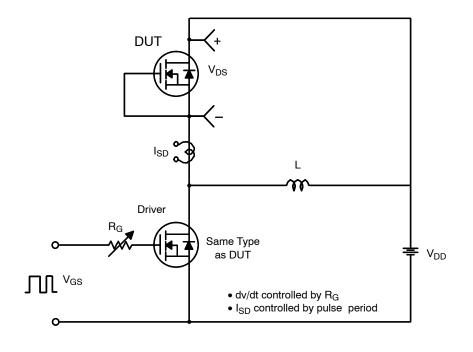


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



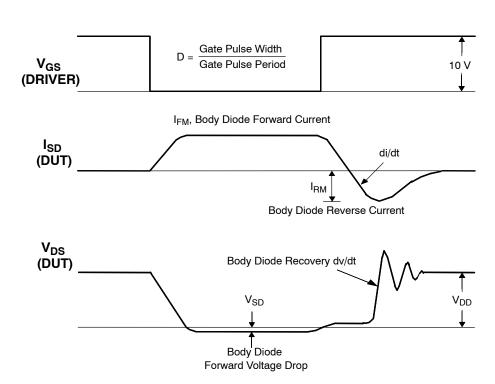
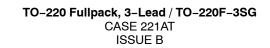
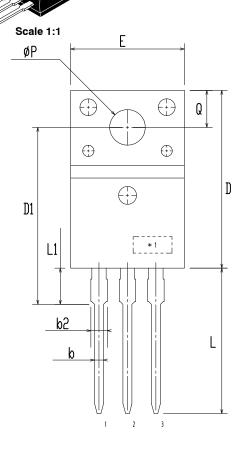
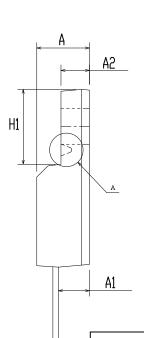


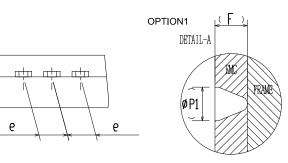
Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



**DATE 19 JAN 2021** 







DIM	MILLIMITERS				
ויונע	MIN	NDM	MAX		
Α	4.50	4.70	4.90		
A1	2.56	2.76	2.96		
A2	2.34	2.54	2.74		
b	0.70	0.80	0.90		
b2	~	~	1.47		
С	0.45	0.50	0.60		
D	15.67	15.87	16.07		
D1	15.60	15.80	16.00		
E	9.96	10.16	10.36		
е	2.34	2.54	2.74		
F	~	0.84	~		
H1	6.48	6.68	6.88		
L	12.78	12.98	13.18		
L1	3.03	3.23	3.43		
ØΡ	2.98	3.18	3.38		
Ø P1	~	1.00	~		
Q	3.20	3.30	3.40		

MILL IMITEDS

#### NOTES:

- A. DIMENSION AND TOLERANCE AS ASME Y14.5-2009
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUCSIONS.

C

C. OPTION 1 - WITH SUPPORT PIN HOLE

**OPTION 2 - NO SUPPORT PIN HOLE** 

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